

AUTOMOTIVE GRADE

AUIRFS3107-7P

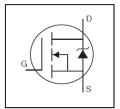
HEXFET® Power MOSFET

Features

- · Advanced Process Technology
- Ultra Low On-Resistance
- Enhanced dV/dT and dI/dT capability
- 175°C Operating Temperature
- · Fast Switching
- · Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V _{DSS}	75V
R _{DS(on)} typ.	2.1mΩ
max.	2.6mΩ
D (Silicon Limited)	260A①
D (Package Limited)	240A



G	D	S
Gate	Drain	Source

Page Port Number	t Number Bookege Type		d Pack	Orderable Part Number	
Base Part Number	Package Type	Form	Quantity	Orderable Part Number	
AUIRFS3107-7P	D²Pak 7 Pin	Tube	50	AUIRFS3107-7P	
AUIRF33107-7P	D Pak / Pill	Tape and Reel Left	800	AUIRFS3107-7PTRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	260①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	190	1 ,
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	240	A
I _{DM}	Pulsed Drain Current ②	1060	
P _D @T _C = 25°C	Maximum Power Dissipation	370	W
	Linear Derating Factor	2.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 3	320	mJ
I _{AR}	Avalanche Current ②	See Fig.14,15, 22a, 22b	Α
E _{AR}	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ®	13	V/ns
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case 9®		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient ®		40	C/VV

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	75			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.083		V/°C	Reference to 25°C, I _D = 5mA ②
R _{DS(on)}	Static Drain-to-Source On-Resistance		2.1	2.6	mΩ	V _{GS} = 10V, I _D = 160A ⑤
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	260			S	V _{DS} = 25V, I _D = 160A
R_G	Gate Resistance		2.1		Ω	
	Dunin to Course Leakens Course			20		$V_{DS} = 75V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 75V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
ı	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	I IIA	V _{GS} = -20V

Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

	<u></u>				
Q_g	Total Gate Charge	 160	240		I _D = 160A
Q_{gs}	Gate-to-Source Charge	 38			$V_{DS} = 38V$
Q_{gd}	Gate-to-Drain Charge	 57		nC	V _{GS} = 10V⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})	 103			
t _{d(on)}	Turn-On Delay Time	 17			V _{DD} = 49V
t _r	Rise Time	 80		no	I _D = 160A
$t_{d(off)}$	Turn-Off Delay Time	 100		ns	$R_G = 2.7\Omega$
t_f	Fall Time	 64			V _{GS} = 10V ^⑤
C _{iss}	Input Capacitance	 9200			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 850			$V_{DS} = 50V$
C _{rss}	Reverse Transfer Capacitance	 400		pF	f = 1.0MHz
Coss eff.(ER)	Effective Output Capacitance (Energy Related)	 1150			V _{GS} = 0V, V _{DS} = 0V to 60V⑦
C _{oss eff.(TR)}	Effective Output Capacitance (Time Related)	 1500			V _{GS} = 0V, V _{DS} = 0V to 60V [©]

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
l.	Continuous Source Current			260①		MOSFET symbol
I _S	(Body Diode)			200⊕	Α	showing the
	Pulsed Source Current		1000	_ ^	integral reverse	
I _{SM}	(Body Diode) ②			1060		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 160A, V_{GS} = 0V $ §
1	Dayaraa Daaayary Tima		52			$T_J = 25^{\circ}C$ $V_{DD} = 64V$
t _{rr}	Reverse Recovery Time		63		ns	$T_J = 125^{\circ}C$ $I_F = 160A$,
0	Reverse Recovery Charge		110		nC	$T_J = 25^{\circ}C$ di/dt = 100A/µs \$
Q_{rr}	Reverse Recovery Charge		160		IIC	<u>T_J = 125°C</u>
I _{RRM}	Reverse Recovery Current		3.8		Α	T _J = 25°C
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ole (turn-on is dominated by L _S +L _D)

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 240A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.026mH, $R_G = 25\Omega$, $I_{AS} = 160$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- ⑤ Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- R_{θJC} value shown is at time zero

2015-10-20



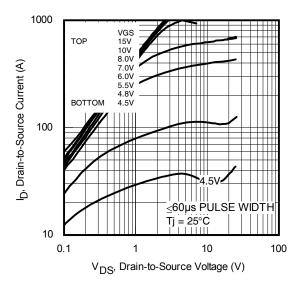


Fig. 1 Typical Output Characteristics

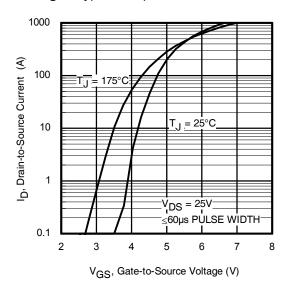


Fig. 3 Typical Transfer Characteristics

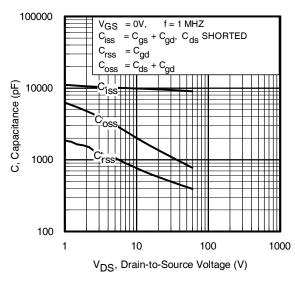


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

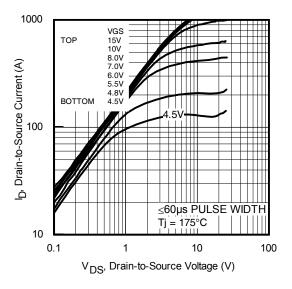


Fig. 2 Typical Output Characteristics

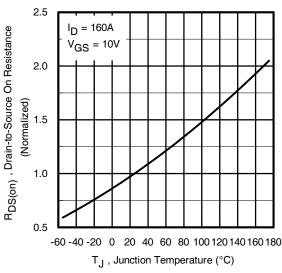


Fig. 4 Normalized On-Resistance vs. Temperature

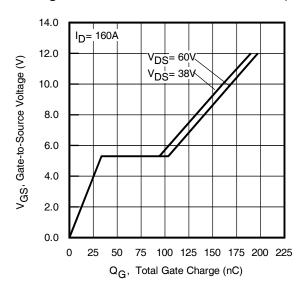


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



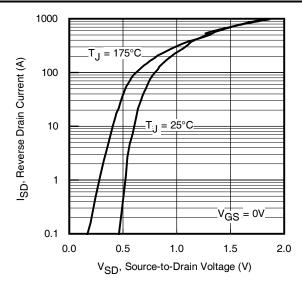


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

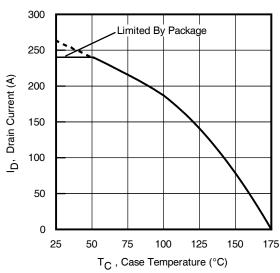


Fig 9. Maximum Drain Current vs. Case Temperature

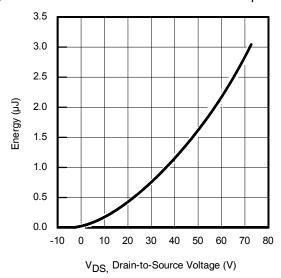


Fig 11. Typical Coss Stored Energy

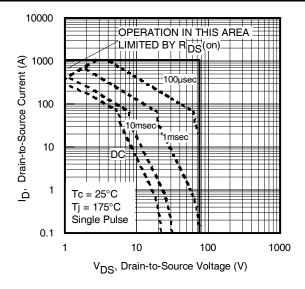


Fig 8. Maximum Safe Operating Area

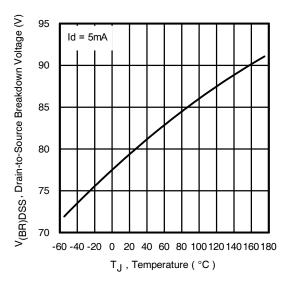


Fig 10. Drain-to-Source Breakdown Voltage

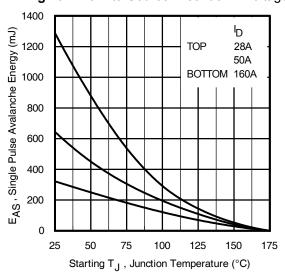


Fig 12. Maximum Avalanche Energy vs. Drain Current



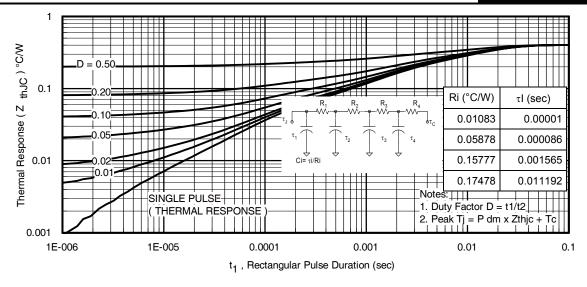


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

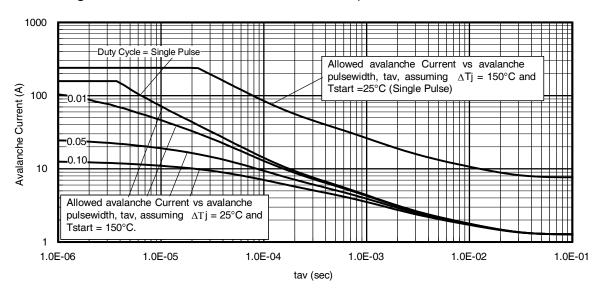


Fig 14. Avalanche Current vs. Pulse width

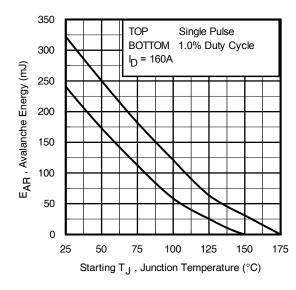


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of Tjmax. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 13, 14).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



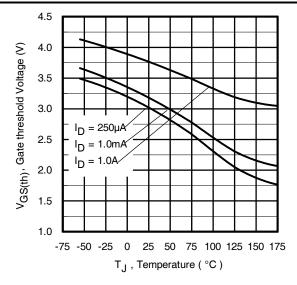


Fig 16. Threshold Voltage vs. Temperature

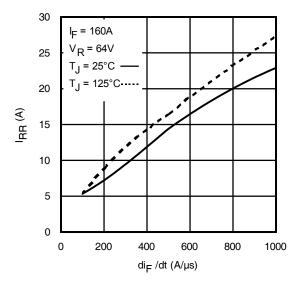


Fig. 18 - Typical Recovery Current vs. dif/dt

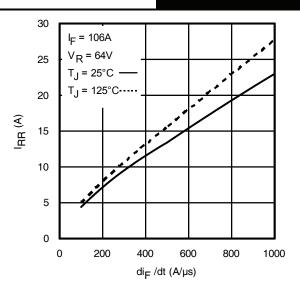


Fig. 17 - Typical Recovery Current vs. dif/dt

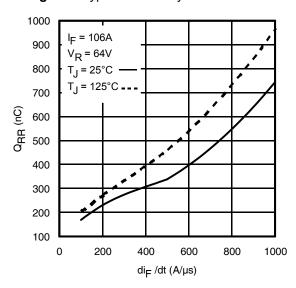


Fig. 19 - Typical Stored Charge vs. dif/dt

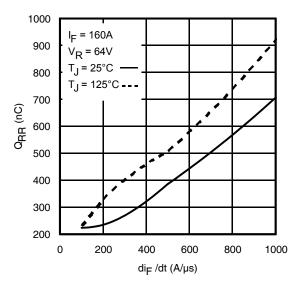


Fig. 20 - Typical Stored Charge vs. dif/dt



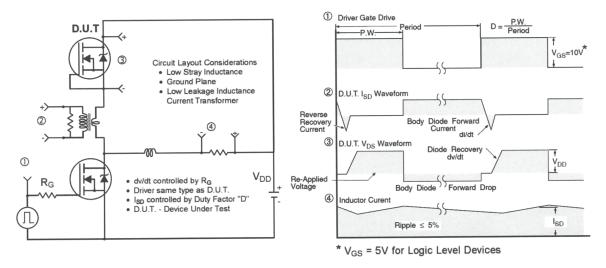


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

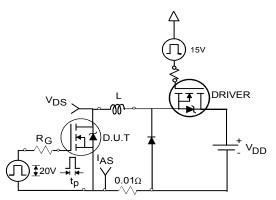


Fig 22a. Unclamped Inductive Test Circuit

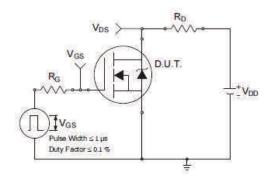


Fig 23a. Switching Time Test Circuit

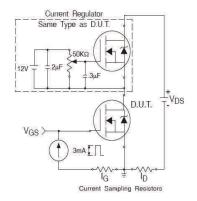


Fig 24a. Gate Charge Test Circuit

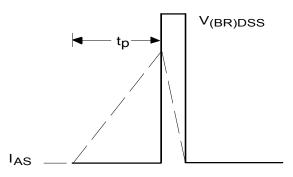


Fig 22b. Unclamped Inductive Waveforms

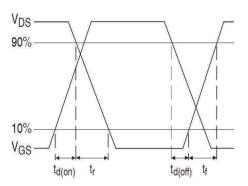


Fig 23b. Switching Time Waveforms

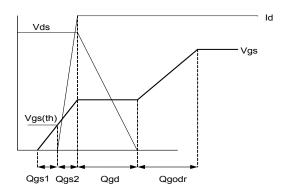
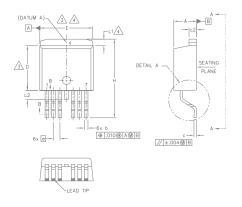
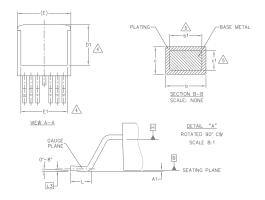


Fig 24b. Gate Charge Waveform



D²Pak - 7 Pin Package Outline (Dimensions are shown in millimeters (inches))





S		DIMEN	ISIONS		N
M B O	MILLIM	ETERS	INC	HES	0 T E S
L	MIN.	MAX.	MIN.	MAX.	E S
Α	4.06	4.83	.160	.190	
A1	_	0.254	_	.010	
ь	0.51	0.99	.020	.036	
b1	0.51	0.89	.020	.032	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	7.42	.270	.292	4
E	9.65	10.54	.380	.415	3,4
E1	6.22	8.48	.245	.334	4
е	1.27	BSC	.050	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	-	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

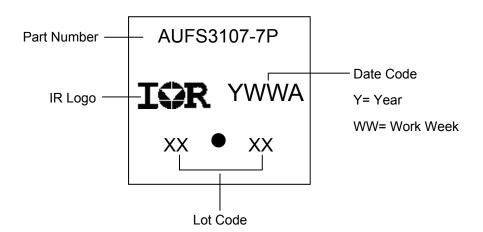
O.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263CB. EXCEPT FOR DIMS. E, E1 & D1.

D²Pak - 7 Pin Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



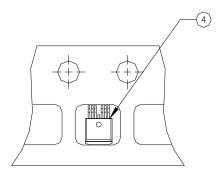
D²Pak - 7 Pin Tape and Reel

NOTES, TAPE & REEL, LABELLING:

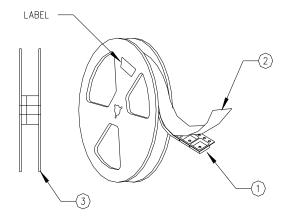
- 1. TAPE AND REEL.
 - 1.1 REEL SIZE 13 INCH DIAMETER.
 - 1.2 EACH REEL CONTAINING 800 DEVICES.
 - 1.3 THERE SHALL BE A MINIMUM OF 42 SEALED POCKETS CONTAINED IN THE LEADER AND A MINIMUM OF 15 SEALED POCKETS IN THE TRAILER.
 - 1.4 PEEL STRENGTH MUST CONFORM TO THE SPEC. NO. 71-9667.
 - 1.5 PART ORIENTATION SHALL BE AS SHOWN BELOW.
 - 1.6 REEL MAY CONTAIN A MAXIMUM OF TWO UNIQUE LOT CODE/DATE CODE COMBINATIONS.

 REWORKED REELS MAY CONTAIN A MAXIMUM OF THREE UNIQUE LOT CODE/DATE CODE COMBINATIONS.

 HOWEVER, THE LOT CODES AND DATE CODES WITH THEIR RESPECTIVE QUANTITIES SHALL APPEAR ON THE BAR CODE LABEL FOR THE AFFECTED REEL.



- 2. LABELLING (REEL AND SHIPPING BAG).
 - 2.1 CUST. PART NUMBER (BAR CODE): IRFXXXXSTRL-7P
 - 2.2 CUST. PART NUMBER (TEXT CODE): IRFXXXXSTRL-7P
 - 2.3 I.R. PART NUMBER: IRFXXXXSTRL-7P
 - 2.4 QUANTITY:
 - 2.5 VENDOR CODE: IR
 - 2.6 LOT CODE:
 - 2.7 DATE CODE:



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

2015-10-20



Qualification Information

		Automotive (per AEC-Q101)				
Qualification	on Level	Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture S	Sensitivity Level	D ² -Pak 7 Pin MSL1				
	Machine Model		Class M4 (+/- 800V) [†]			
	Machine Model	AEC-Q101-002				
ESD	Human Bady Madal	Class H3A (+/- 6000V) [†]				
ESD	Human Body Model	AEC-Q101-001				
Charried Davies Madel		Class C5 (+/- 2000V) [†]				
	Charged Device Model		AEC-Q101-005			
RoHS Com	pliant	Yes				

[†] Highest passing voltage.

Revision History

Date	Comments				
10/20/2015	Updated datasheet with corporate template				
10/20/2015	Corrected ordering table on page 1.				

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